

**Notice of References Cited**

Application/Control No.

09/748,520

Applicant(s)/Patent Under  
Reexamination  
GUPTA ET AL.

Examiner

Uyen T Le

Art Unit

2171

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0156694	10-2002	Christensen et al.	705/26
*	B	US-5,369,570	11-1994	Parad, Harvey A.	705/8
*	C	US-6,463,345	10-2002	Peachey-Kountz et al.	700/99
*	D	US-5,905,496	05-1999	Lau et al.	345/835
*	E	US-4,975,841	12-1990	Kehnemuyi et al.	705/32
*	F	US-6,292,784	09-2001	Martin et al.	705/11
*	G	US-6,345,259	02-2002	Sandoval, Gerald A.	705/7
*	H	US-6,032,121	02-2000	Dietrich et al.	705/8
*	I	US-2002/0042756	04-2002	Kumar et al.	705/26
*	J	US-2002/0188499	12-2002	Jenkins et al.	705/10
*	K	US-2002/0016729	02-2002	Breitenbach et al.	705/9
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.